

Edition 1.0 2016-04

INTERNATIONAL STANDARD



Instrument transformers -

Part 6: Additional general requirements for low-power instrument transformers

INTERNATIONAL ELECTROTECHNICAL COMMISSION

ICS 17.220.20 ISBN 978-2-8322-3330-6

Warning! Make sure that you obtained this publication from an authorized distributor.

CONTENTS

1	Scope	10
2	Normative reference	10
3	Terms and definitions	13
	3.1 General terms and definitions	
	3.2 Terms and definitions related to dielectric ratings and voltages	
	3.3 Terms and definitions related to current ratings	
	3.4 Terms and definitions related to accuracy	
	3.5 Terms and definitions related to other ratings	
	3.7 Index of abbreviations and symbols	
4	Normal and special service conditions	28
	4.2 Normal service conditions	28
	4.2.3 Vibrations or earth tremors	28
	4.2.601 Partially outdoor LPIT	
5	Ratings	28
	5.3 Rated insulation levels and voltages	28
	5.3.5 Insulation requirements for secondary terminals	
	5.3.601 Rated auxiliary power supply voltage (U_{ar})	
	5.4 Rated frequency	
	5.5 Rated output	
	5.5.601 Rated burden (R _{br})	
	5.5.602 Standard values for the rated delay time (t_{dr})	
	5.6 Rated accuracy class	
6	Design and construction	30
	6.7 Mechanical requirements	30
	6.11 Electromagnetic compatibility (EMC)	30
	6.11.3 Requirements for immunity	30
	6.11.4 Requirement for transmitted overvoltages	32
	6.11.601 Emission requirements	32
	6.13 Markings	33
	6.601 Requirements for optical transmitting system and optical output link	33
	6.601.1 General	33
	6.601.2 Optical connectors	33
	6.601.3 Fibre optic terminal box	33
	6.601.4 Total cable length	33
	6.602 Requirements for electrical transmitting system and electrical wires for output link	33
	6.602.1 Connectors	
	6.602.2 Earthing of the output cable	
	6.603 Signal-to-noise ratio	
	6.604 Failure detection and maintenance announcement	
	6.605 Operability	
	6.606 Reliability and dependability	
	6.607 Vibrations	
7	Tests	36
	7.1 General	36

7.1.2	<u>.</u>	List of tests	36
7.2	Туре	e tests	37
7.2.1		General	37
7.2.2	<u>.</u>	Temperature-rise test	37
7.2.3	}	Impulse voltage withstand test on primary terminals	37
7.2.5	;	Electromagnetic compatibility (EMC) tests	37
7.2.6	;	Test for accuracy	41
7.2.6	01	Low-voltage component voltage withstand test	43
7.3	Rou	tine tests	44
7.3.1		Power-frequency voltage withstand tests on primary terminals	44
7.3.4	•	Power-frequency voltage withstand tests on secondary terminals	45
7.3.5	,	Test for accuracy	45
7.3.6	01	Power-frequency voltage withstand test for low-voltage components	45
7.4	Spe	cial tests	45
7.4.6	01	Vibration tests	45
601 Infor	matic	on to be given with enquiries, tenders and orders	46
601.1	Des	ignation	46
601.2	Dep	endability	46
	•	mative) LPIT frequency response and accuracy requirements for	47
6A.1	Gen	eral	47
6A.2		uirements for noise and distortion	
6A.3		-aliasing filter requirements for LPIT using digital data processing	
6A.4		Faccuracy requirements for harmonics and low frequencies	
6A.4		General	
6A.4		Measuring accuracy classes	
6A.4		Accuracy class extension for quality metering and low bandwidth d.c. applications	
6A.4	1	Protective accuracy classes	
6A.4		Special high bandwidth protection accuracy class	
6A.4		Special accuracy classes for d.c. coupled low-power voltage	
0A.4	.0	transformers	52
6A.5	Test	s for accuracy versus harmonics and low frequencies	
6A.6		t arrangement and test circuit	
6A.6		Test for accuracy for harmonics and low frequencies	
6A.6	.2	Type test for proper anti-aliasing	
	•	ormative) Transient performances of low-power current transformers	55
6B.1		eral	
6B.2		rt-circuit currents in power systems	
6B.3		ventional current transformer equivalent circuit	
6B.4		es of current transformers	
6B.4		Types of conventional CTs	
6B.4		Types of low-power current transformers	
6B.5		nsient performance of current transformers	
6B.5		Transient performance of conventional current transformers	
6B.5		Transient performance of low-power current transformers	
6B.6		nmary	
Annex 6C	(Into	ormative) Transient performances of low-power voltage transformers	65
~~ 4	^	m; =	~ -

6C.2	General	65
6C.2	.1 Defining primary and secondary voltages	65
6C.2	Normal service conditions of the network	65
6C.2		
6C.2	,	
6C.2	,	
	Transient conditions	
6C.3		
6C.3 6C.3		
	3.3 Test of transient performance	
6D.1	Test circuits for accuracy measurements in steady state for low-power	70
ו.עס	current transformers	78
6D.2	Test circuits for accuracy measurements in steady state for low-power voltage transformers	81
	(informative) Graph explaining the accuracy requirements for multi-purpose or current transformer	84
Bibliograp	phy	85
•	11 – General block diagram of a single-phase LPIT	
Figure 60	$^{\circ}$ 2 – Primary time constant T_{p}	19
Figure 60	3 – Duty cycles, single energization	20
Figure 60	94 – Duty cycles, double energization	21
	95 – Examples of subassembly subjected to EMC tests – Usual structure used S applications	38
	06 – Examples of subassembly subjected to EMC tests – Usual structure used plications	39
	7 – Examples of subassembly subjected to EMC tests – Usual structure used Sapplications	39
	98 – Temperature cycle accuracy test	
•	A.1 – Digital data acquisition system example	
Figure 6A	$\lambda.2$ – Frequency response mask for metering accuracy class 1 (f_{Γ} = 60 Hz, f_{S} =	
4 800 Hz)	49
Figure 6E	3.1 – Illustration of a fault in a power system	56
Figure 6E	3.2 – Short-circuit current a.c. and d.c. components	56
Figure 6E	3.3 – Symmetric fault current	57
Figure 6E	3.4 – Asymmetric fault current	57
Figure 6E	3.5 – Equivalent electrical circuit of a conventional CT	58
	3.6 – Flux-current characteristic for a conventional CT without remanence tation	59
Figure 6E	3.7 – Representation of hysteresis and remanent flux for a conventional CT	60
Figure 6E	3.8 – Comparison of flux-current characteristics for gapped and gapless CTs	62
Figure 6E	B.9 – Secondary current distorted due to the CT saturation	63
_	3.10 – AC component for non-saturated and saturated CT	
	C.1 – Schematic diagram explaining the trapped charge phenomena	
_	C.2 – Voltages during trapped charges phenomena	
•	C.3 – Modelization example of a simplified low-power voltage transformer	
J	1 1 2 1 1 2 1 3 1 3 1 3 1 3 1 3 1 3 1 3	_

Figure 6C.4 – Testing arrangement for short time constant	76
Figure 6C.5 – Testing arrangement for long time constant	77
Figure 6C.6 – Typical waveform of $e(t)$ during test	77
Figure 6D.1 – Test circuit for analogue accuracy measurements in steady state	78
Figure 6D.2 – Test circuit for analogue accuracy measurements in steady state (alternative solution)	79
Figure 6D.3 – Test circuit for digital accuracy measurements in steady state	80
Figure 6D.4 – Test circuit for analogue accuracy measurements in steady state	81
Figure 6D.5 – Test circuit for analogue accuracy measurements in steady state (alternative solution)	82
Figure 6D.6 – Test circuit for digital accuracy measurements in steady state	83
Figure 6E.1 – Accuracy limits of a multi-purpose low-power current transformer	84
Table 601 – Secondary terminal and low voltage component withstand capability	28
Table 602 – Immunity requirements and tests	30
Table 603 – Connectors	34
Table 10 – List of tests	36
Table 6A.1 – Anti-aliasing filter	48
Table 6A.2 – Measuring accuracy classes	50
Table 6A.3 – Accuracy classes extension for quality metering and low bandwidth d.c. applications	50
Table 6A.4 – Accuracy classes extension for high bandwidth d.c. applications	51
Table 6A.5 – Protective accuracy classes	51
Table 6A.6 – Accuracy classes for special high bandwidth protection	52
Table 6A.7 – Accuracy classes for special d.c. coupled low-power voltage transformers	52
Table 6A.8 – Accuracy classes for harmonics	53
Table 6B.1 – Protective CTs	61
Table 6C.1 – Primary short circuit	71
Table 6C.2 – Trapped charges	71
Table 6C.3 – Limits of instantaneous voltage error for protective electronic voltage transformers in case of trapped charges reclose.	71

INTERNATIONAL ELECTROTECHNICAL COMMISSION

INSTRUMENT TRANSFORMERS -

Part 6: Additional general requirements for low-power instrument transformers

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61869-6 has been prepared by IEC technical committee 38: Instrument transformers.

This first edition of IEC 61869-6 cancels and replaces the relevant parts of IEC 60044-7, published in 1999, and of IEC 60044-8, published in 2002¹.

¹ IEC 60044-7 and IEC 60044-8 will eventually be replaced by the IEC 61869 series, but until all the relevant parts will be published, these two standards are still in force.

The text of this standard is based on the following documents:

FDIS	Report on voting
38/501/FDIS	38/507/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61869 series, published under the general title *Instrument transformers*, can be found on the IEC website.

This Part 6 is to be read in conjunction with, and is based on, IEC 61869-1:2007, *General Requirements* – however, the reader is encouraged to use its most recent edition.

This Part 6 follows the structure of IEC 61869-1:2007 and supplements or modifies its corresponding clauses.

When a particular clause/subclause of Part 1 is not mentioned in this Part 6, that clause/subclause applies. When this standard states "addition", "modification" or "replacement", the relevant text in Part 1 is to be adapted accordingly.

For additional clauses, subclauses, figures, tables, annexes or notes, the following numbering system is used:

- clauses, subclauses, tables, figures and notes that are numbered starting from 601 are additional to those in Part 1;
- additional annexes are lettered 6A, 6B, etc.

An overview of the planned set of standards at the date of publication of this document is given below. The updated list of standards issued by IEC TC 38 is available at the website: www.iec.ch.

PRODUCT FAMILY STANDARDS		PRODUCT STANDARD IEC	PRODUCTS	OLD STANDARD IEC
		61869-2	ADDITIONAL REQUIREMENTS FOR CURRENT TRANSFORMERS	60044-1
				60044-6
		61869-3	ADDITIONAL REQUIREMENTS FOR INDUCTIVE VOLTAGE TRANSFORMERS	60044-2
		61869-4	ADDITIONAL REQUIREMENTS FOR COMBINED TRANSFORMERS	60044-3
IEC 61869-1	EC 61869-1		ADDITIONAL REQUIREMENTS FOR CAPACITOR VOLTAGE TRANSFORMERS	60044-5
GENERAL REQUIREMENTS FOR	IEC 61869-6 ADDITIONAL GENERAL REQUIREMENTS FOR LOW-POWER INSTRUMENT TRANSFORMERS	61869-7	ADDITIONAL REQUIREMENTS FOR ELECTRONIC VOLTAGE TRANSFORMERS	60044-7
INSTRUMENT TRANSFORMERS		61869-8	ADDITIONAL REQUIREMENTS FOR ELECTRONIC CURRENT TRANSFORMERS	60044-8
		61869-9	DIGITAL INTERFACE FOR INSTRUMENT TRANSFORMERS	
		61869-10	ADDITIONAL REQUIREMENTS FOR LOW- POWER PASSIVE CURRENT TRANSFORMERS	
		61869-11	ADDITIONAL REQUIREMENTS FOR LOW- POWER PASSIVE VOLTAGE TRANSFORMERS	
		61869-12	ADDITIONAL REQUIREMENTS FOR COMBINED ELECTRONIC INSTRUMENT TRANSFORMER OR COMBINED PASSIVE TRANSFORMERS	
		61869-13	STAND ALONE MERGING UNIT	
		61869-14	ADDITIONAL REQUIREMENTS FOR CURRENT TRANSFORMERS FOR DC APPLICATIONS	
		61869-15	ADDITIONAL REQUIREMENTS FOR DC VOLTAGE TRANSFORMERS FOR DC APPLICATIONS	

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- · reconfirmed,
- withdrawn,
- · replaced by a revised edition, or
- · amended.

A bilingual version of this publication may be issued at a later date.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INSTRUMENT TRANSFORMERS -

Part 6: Additional general requirements for low-power instrument transformers

1 Scope

This part of IEC 61869 is a product family standard and covers only additional general requirements for low-power instrument transformers (LPIT) used for a.c. applications having rated frequencies from 15 Hz to 100 Hz covering MV, HV and EHV or used for d.c. applications. This product standard is based on IEC 61869-1:2007, in addition to the relevant product specific standard.

This part of IEC 61869 does not cover the specification for the digital output format of instrument transformers.

This part of IEC 61869 defines the errors in case of analogue or digital output. The other characteristics of the digital interface for instrument transformers are standardised in IEC 61869-9 as an application of the standards, the IEC 61850 series, which details layered substation communication architecture.

This part of IEC 61869 considers additional requirements concerning bandwidth. The accuracy requirements on harmonics and requirements for the anti-aliasing filter are given in the normative Annex 6A.4.

The general block diagram of single-phase LPITs is given in Figure 601.

According to the technology, it is not absolutely necessary that all parts described in Figure 601 are included in the instrument transformer.

As an example, for low-power passive transformers (LPITs without active electronic components) the blocks are composed only with passive components and there is no power supply.

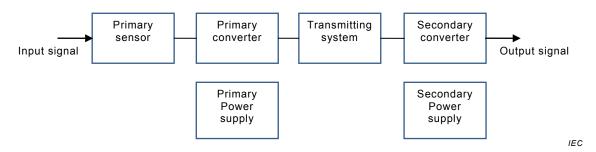


Figure 601 – General block diagram of a single-phase LPIT

2 Normative reference

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

Clause 2 of IEC 61869-1:2007 is applicable with the following additions:

IEC 60068-2-6:2007, Environmental testing – Part 2-6: Tests – Test Fc: Vibration (sinusoidal)

IEC 60255-27:2013, Measuring relays and protection equipment – Part 27: Product safety requirements

IEC 60603-7-1:2011, Connectors for electronic equipment – Part 7-1: Detail specification for 8-way, shielded, free and fixed connectors

IEC 60794-2:2002, Optical fibre cables - Part 2: Indoor cables - Sectional specification

IEC 60794-3:2014, Optical fibre cables – Part 3: Outdoor cables – Sectional specification

IEC 60812:2006, Analysis techniques for system reliability – Procedure for failure mode and effects analysis (FMEA)

IEC 61000-4-1:2006, Electromagnetic compatibility (EMC) – Part 4-1: Testing and measurement techniques – Overview of IEC 61000-4 series

IEC 61000-4-2:2008, Electromagnetic compatibility (EMC) – Part 4-2: Testing and measurement techniques – Electrostatic discharge immunity test

IEC 61000-4-3:2006, Electromagnetic compatibility (EMC) – Part 4-3: Testing and measurement techniques – Radiated, radio-frequency, electromagnetic field immunity test IEC 61000-4-3:2006/AMD1:2007 IEC 61000-4-3:2006/AMD2:2010

IEC 61000-4-4:2012, Electromagnetic compatibility (EMC) – Part 4-4: Testing and measurement techniques – Electrical fast transient/burst immunity test

IEC 61000-4-5:2014, Electromagnetic compatibility (EMC) – Part 4-5: Testing and measurement techniques – Surge immunity test

IEC 61000-4-6:2013, Electromagnetic compatibility (EMC) – Part 4-6: Testing and measurement techniques – Immunity to conducted disturbances, induced by radio-frequency fields

IEC 61000-4-7:2002, Electromagnetic compatibility (EMC) – Part 4-7: Testing and measurement techniques – General guide on harmonics and interharmonics measurements and instrumentation, for power supply systems and equipment connected thereto IEC 61000-4-7:2002/AMD1:2008

IEC 61000-4-8:2009, Electromagnetic compatibility (EMC) – Part 4-8: Testing and measurement techniques – Power frequency magnetic field immunity test

IEC 61000-4-9:1993, Electromagnetic compatibility (EMC) – Part 4-9: Testing and measurement techniques – Section 9: Pulse magnetic field immunity test IEC 61000-4-9:1993/AMD1:2000

IEC 61000-4-10:1993, Electromagnetic compatibility (EMC) – Part 4-10: Testing and measurement techniques –Section 10: Damped oscillatory magnetic field immunity test. Basic EMC Publication

IEC 61000-4-10:1993/AMD1:2000

IEC 61000-4-11:2004, Electromagnetic compatibility (EMC) – Part 4-11: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations immunity tests

IEC 61000-4-13:2002, Electromagnetic compatibility (EMC) – Part 4-13: Testing and measurement techniques – Harmonics and interharmonics including mains signalling at a.c. power port, low frequency immunity tests IEC 61000-4-13:2002/AMD1:2009

IEC 61000-4-16:1998, Electromagnetic compatibility (EMC) – Part 4-16: Testing and measurement techniques – Test for immunity to conducted, common mode disturbances in the frequency range 0 Hz to 150 kHz

IEC 61000-4-16:1998/AMD1:2001 IEC 61000-4-16:1998/AMD2:2009

IEC 61000-4-18:2006, Electromagnetic compatibility (EMC) – Part 4-18: Testing and measurement techniques – Damped oscillatory wave immunity test IEC 61000-4-18:2006/AMD1:2010

IEC 61000-4-29:2000, Electromagnetic compatibility (EMC) – Part 4-29: Testing and measurement techniques – Voltage dips, short interruptions and voltage variations on d.c. input power port immunity tests

IEC 61025:2006, Fault tree analysis (FTA)

IEC 61076-2-101:2012, Connectors for electronic equipment – Product requirements – Part 2-101: Circular connectors – Detail specification for M12 connectors with screw-locking

IEC TS 61850-2:2003, Communication networks and systems in substations – Part 2: Glossary

IEC 61850-7-4:2010, Communication networks and systems for power utility automation – Part 7-4: Basic communication structure – Compatible logical node classes and data object classes

IEC 61869-1:2007. Instrument transformers – Part 1: General requirements

IEC 61869-2:2012, Instrument transformers – Part 2: Additional requirements for current transformers

IEC 61869-3:2011, Instrument transformers – Part 3: Additional requirements for inductive voltage transformers

IEC TR 61869-103:2012, Instrument transformers – Part 103: The use of instrument transformers for power quality measurement

IEC 62271-100:2008, High-voltage switchgear and controlgear – Part 100: Alternating current circuit-breakers
IEC 62271-100:2008/AMD1:2012

CISPR 11:2015, Industrial, scientific and medical equipment – Radio-frequency disturbance characteristics – Limits and methods of measurement

ISO/IEC/IEEE 21451-4:2010, Information technology – Smart transducer interface for sensors and actuators – Part 4: Mixed-mode communication protocols and Transducer Electronic Data Sheet (TEDS) formats

EN 50160:2010, Voltage characteristics of electricity supplied by public distribution systems